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54AC16245 ... WD PACKAGE

- Members of the Texas Instruments Widebus[™] Family
- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- Flow-Through Architecture Optimizes PCB Layout
- Distributed V_{CC} and GND Configuration Minimizes High-Speed Switching Noise
- EPIC ™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Thin Shrink Small-Outline (DGG) Package, 300-mil Shrink Small-Outline (DL) Package Using 25-mil Center-to-Center Pin Spacings and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Pin Spacings

description

The 'AC16245 are 16-bit bus transceivers organized as dual-octal noninverting 3-state transceivers designed for asynchronous two-way communication between data buses. The control function implementation minimizes external timing requirements

These devices allow data transmission from the A bus to the B bus or from the B bus to the A bus, depending upon the logic level at the direction control (DIR) input. The output-enable input (\overline{OE}) can be used to disable the devices so that the buses are effectively isolated.

The 74AC16245 is packaged in TI's shrink small-outline package, which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The 54AC16245 is characterized for operation over the full military temperature range of -55° C to 125°C. The 74AC16245 is characterized for operation from -40° C to 85°C.

		1 0110	HON TABLE
- 1	CONTROL INPUTS		OPERATION
2	OE	DIR	
13	L	L	B data to A bus
	L	Н	A data to bus
	Н	Х	Isolation

FUNCTION TABLE

$\overline{\Delta}$	$\overline{\Delta}$

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

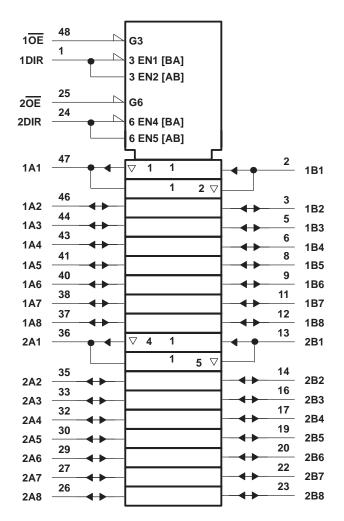
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		DL PACKAGE
	Evv)	TIM
10	48] 10E
2	47] 1A1
3	46]1A2
4	45] GND
5	44] 1A3
6] 1A4
7	42] V _{CC}
8] 1A5
9	40] 1A6
10	39] GND
11	38] 1A7
12	37] 1A8
13	36] 2A1
14	35] 2A2
15	34] GND
16	33] 2A3
17	32] 2A4
18	31	V _{CC}
19	30] 2A5
	29] 2A6
21	28] GND
22	27	2A7
23	26	2A8
24	25	20E
	(TOP VI 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23	1 48 2 47 3 46 4 45 5 44 6 43 7 42 8 41 9 40 10 39 11 38 12 37 13 36 14 35 15 34 16 33 17 32 18 31 19 30 20 29 21 28 22 27 23 26

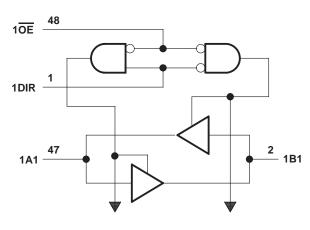
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logic symbol[†]

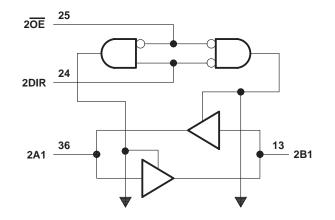


[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Transceivers



To Seven Other Transceivers



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

	Input Outpu Input Outpu Conti
Continuous current through V _{CC} or GND ±400 mA	Conti
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DGG package 0.85 W	Maxir
DL package	
Storage temperature range, T _{stg} 65°C to 150°C	Stora

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

			54	54AC16245 74AC16245		5				
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage (see Note 4)		3	5	5.5	3	5	5.5	V	
		$V_{CC} = 3 V$	2.1			2.1				
VIH	High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15			V	
		$V_{CC} = 5.5 V$	3.85			3.85				
		VCC = 3 V			0.9			0.9		
VIL	Low-level input voltage	$V_{CC} = 4.5 V$		1	1.35			1.35	V	
		V _{CC} = 5.5 V		3EI	1.65			1.65		
VI	Input voltage		0	2	VCC	0		VCC	V	
VO	Output voltage		0	5	VCC	0		VCC	V	
		VCC = 3 V	40	-4				-4		
IOH	High-level output current	V _{CC} = 4.5 V	40		-24			-24	mA	
		$V_{CC} = 5.5 V$			-24			-24		
		$V_{CC} = 3 V$			12			12		
IOL	Low-level output current	V _{CC} = 4.5 V			24			24	mA	
		V _{CC} = 5.5 V			24			24		
$\Delta t/\Delta v$	Input transition rise or fall rate		0		10	0		10	ns/V	
T _A	Operating free-air temperature		-55		125	-40		85	°C	

recommended operating conditions (see Note 3)

NOTES: 3. All unused pins (input and I/O) must be held high or low to prevent them from floating.

4. All V_{CC} and GND pins must be connected to the proper voltage power supply.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CONDITIONS	N	T _A = 25°C			54AC1	6245	74AC16245		
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		3 V	2.9			2.9		2.9		
	I _{OH} = -50 μA	4.5 V	4.4			4.4		4.4		
		5.5 V	5.4			5.4		5.4		
VOH	I _{OH} = -4 mA	3 V	2.58			2.48		2.48		V
		4.5 V	3.94			3.8		3.8		
	I _{OH} = -24 mA	5.5 V	4.94			4.8		4.8		
	I _{OH} = -75 mA [†]	5.5 V				3.85	EV,	3.85		
		3 V			0.1		0.1		0.1	UNIT
	I _{OL} = 50 μA	4.5 V			0.1		ັ 0.1		0.1	
		5.5 V			0.1	(C)	0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36	la a	0.44		0.44	
	lat = 24 mA	4.5 V			0.36	5	0.44		0.44	
	I _{OL} = 24 mA	5.5 V			0.36	-	0.44		0.44	
	I _{OL} = 75 mA [†]	5.5 V					1.65		1.65	
lj	$V_{I} = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ
I _{OZ}	$V_{I} = V_{CC}$ or GND	5.5 V			±0.5		±5		±5	μΑ
ICC	$V_{I} = V_{CC} \text{ or GND}, \qquad I_{O} = 0$	5.5 V			8		80		80	μΑ
Ci	$V_{I} = V_{CC}$ or GND	5 V		4.5						~ Г
Co	$V_{I} = V_{CC} \text{ or } GND$	5 V		16						pr

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

 \ddagger For I/O ports, the parameter I_{OZ} includes the input leakage current.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			54AC16245		74AC16245		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	B or A	2.5	7.6	10.4	2.5	11.9	2.5	11.9	ns
^t PHL			3.1	9	12.3	3.1	13.5	3.1	13.5	
^t PZH	ŌĒ	A or B	2.8	8.6	11.8	2.8	1 3.2	2.8	13.2	
^t PZL			3.9	12	16.2	3.9	18	3.9	18	ns
^t PHZ	OE	A or B	5.3	8.4	10.4	5.3	11.2	5.3	11.2	20
^t PLZ	UE		4.4	7.7	9.7	2 4.4	10.3	4.4	10.3	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (see Figure 1)

PARAMETER	FROM	FROM TO			T _A = 25°C			74AC16245		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
^t PLH	A or B	B or A	2	4.6	6.9	2	7.9	2	7.9	ns
^t PHL	AUB	BUIA	2.5	5.2	7.9	2.5	8.9	2.5	8.9	
^t PZH		A or B	2.3	4.9	7.5	2.3	8.6	2.3	8.6	ns
^t PZL	OE	AUID	3	6.2	9.5	30)	10.7	3	10.7	
^t PHZ	OE	A or B	5	7.2	9.1	05	9.8	5	9.8	ns
^t PLZ	UE UE	A OF B	4.2	6.2	8.1	4 .2	8.7	4.2	8.7	115

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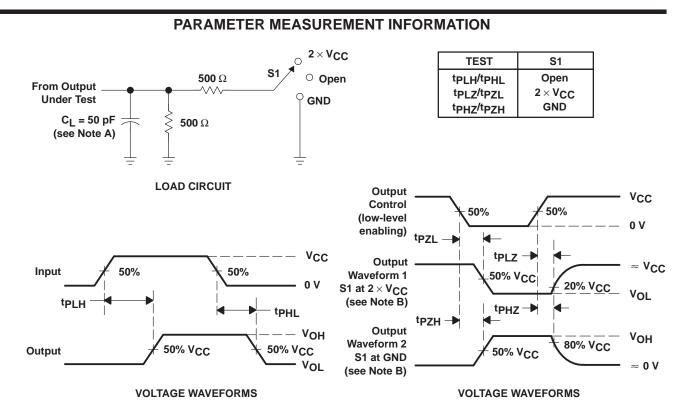


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operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER			TEST CON	TYP	UNIT	
C _{pd}	Dower dissinction experitones per lateh	Outputs enabled	$C_{1} = 50 \text{ pE}$	f = 1 MHz	43	.
	Power dissipation capacitance per latch	Outputs disabled	C _L = 50 pF,	t = 1 MHz	8	p⊦



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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